# FCC PART 15 SUBPART C

# EMI MEASUREMENT AND TEST REPORT

For

## Ambit Microsystems Corporation

4-1, Ming Shen Street, Tu Chen Industrial District. Tu Chen, Taipei Hsien 236, Taiwan, R.O.C.

FCC ID: MCLT60M665

2004-01-29						
This Report Co	ncerns:	Equipment Type:				
Permissive C	hange Report	Bluetooth Wireless Card in Notebook PC				
Test Engineer:	Ling Zhang /	had synd				
Report No.:	R0401093					
Test Deter	2004 01 15					
Test Date:	2004-01-15					
Reviewed By:	Ming Jing / Bay	jan Jug				
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**Note:** This test report is specially limited to the above client company and product model only. It may not be duplicated without prior written consent of Bay Area Compliance Laboratory Corporation. This report **must not** be used by the client to claim product endorsement by NVLAP or any agency of the U.S. Government.

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### **GENERAL INFORMATION**

### **Product Description for Equipment Under Test (EUT)**

The *Ambit Microsystems Corporation*'s Model: *T60M665* or the "EUT" as referred to in this report is a Wireless Card & Antenna installed in the ACER notebook PC. During the test the EUT was connected to the Hon Hai Precision Industry Co., Ltd. Antenna (model: WDAN-01DT3002). The wireless card measures approximately 2.4" L x 1.7" W x 0.1"H.

\* The test data gathered are from production sample, serial number: B0032, provided by the manufacturer.

### Objective

This type approval report is prepared on behalf of *Ambit Microsystems Corporation* in accordance with Part 2, Subpart J, Part 15, Subparts A and C of the Federal Communication Commissions rules.

This is a PCII application. The original application was granted on 3/19/03. The difference between the original device and the current one is the EUT was connected with a new antenna manufactured by Hon Hai Precision Industry Co., Lt.d. Please see the Antenna Specification for the detailed information.

The objective is to determine compliance with FCC rules Conducted and Spurious Radiated Emission.

### **Related Submittal(s)/Grant(s)**

The PCII application was originally granted on 3/19/03. Please refer to BACL report R0301173 for the details of the original application.

### **Test Methodology**

All measurements contained in this report were conducted with ANSI C63.4-2001, American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the range of 9 kHz to 40 GHz and FCC97114 for Direct Sequence SS.

All radiated and conducted emissions measurement was performed at Bay Area Compliance Laboratory, Corp. The radiated testing was performed at an antenna-to-EUT distance of 3 meters.

### **Test Facility**

The Open Area Test site used by BACL to collect radiated and conducted emission measurement data is located in the back parking lot of the building at 230 Commercial Street, Sunnyvale, California, USA.

Test site at BACL has been fully described in reports submitted to the Federal Communication Commission (FCC) and Voluntary Control Council for Interference (VCCI). The details of these reports has been found to be in compliance with the requirements of Section 2.948 of the FCC Rules on February 11 and December 10, 1997 and Article 8 of the VCCI regulations on

December 25, 1997. The facility also complies with the radiated and AC line conducted test site criteria set forth in ANSI C63.4-2001.

#### Ambit Microsystems Corporation

The Federal Communications Commission and Voluntary Control Council for Interference has the reports on file and is listed under FCC file 31040/SIT 1300F2 and VCCI Registration No.: C-1298 and R-1234.

The test site has been approved by the FCC and VCCI for public use and is listed in the FCC Public Access Link (PAL) database.

Additionally, BACL is a National Institute of Standards and Technology (NIST) accredited laboratory, under the National Voluntary Laboratory Accredited Program (Lab Code 200167-0). The scope of the accreditation covers the FCC Method – 47 CFR Part – Digital Devices, CISPER 22: 1997: Electromagnetic Interference – Limits and Methods of Measurement of Information Technology Equipment test methods.

Manufacturer	Description	Model	Serial Number	FCC ID
ACER	Notebook PC	DT3	QCHTU34500013	DOC
HP	Printer	2225C	N/A	DOC
EVEREX	Modem	EV-945	12006A8EX0- 09A08	E3E5UVEV-945

### Local Support Equipment List and Details

### External I/O Cabling List and Details

Cable Description	Length (M)	Port/From	То
Shielded Printer Cable	1.5	Parallel Port/Notebook PC	Printer
Shielded Serial Cable	1.5	Serial Port/Notebook PC	Modem

### **Power Supply Information**

Manufacturer	Description	Model	Serial Number	FCC ID
LITEON	AC Adapter	PA-1181-08QA	3X0000490A	DOC

### SYSTEM TEST CONFIGURATION

### Justification

The host system was configured for testing according to ANSI C63.4-2001.

The EUT was tested in the normal (native) operating mode to represent *worst*-case results during the final qualification test.

### **EUT Exercise Software**

The EUT exercising program used during radiated and conducted testing was designed to exercise the various system components in a manner similar to a typical use. The test software, bluetest, provided by the customer, is started the Windows 98 terminal program under the Windows 98 operating system. Once started, select USB from "choose a protocol", select TXDATA1 from "bluetest" then click execute. The process is continuous throughout all tests.

### **Special Accessories**

As shown in following test set up block diagram, all interface cables used for compliance testing are shielded. The notebook and the peripherals featured shielded metal connectors.

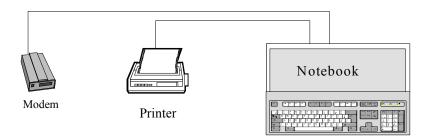
### **Schematics / Block Diagram**

Please refer to Appendix A.

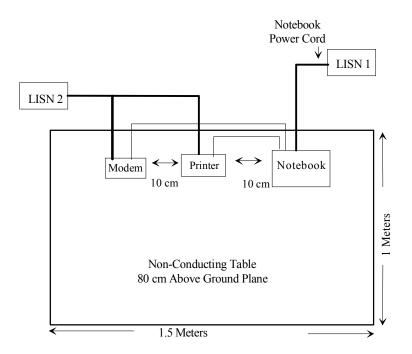
### **Equipment Modifications**

No modifications were made to the EUT.

### **Configuration of Test System**



### **Test Setup Block Diagram**



## SUMMARY OF TEST RESULTS

Results reported relate only to the product tested, serial number: B0032.

FCC RULES	DESCRIPTIONOFTEST	RESULT
§15.203	Antenna Requirement	Compliant
§ 15.205, §15.209(a)	Restricted Bands, Radiated Emission	Compliant
§ 15.207(a)	AC Line Conduction	Compliant

## §15.203 - ANTENNA REQUIREMENT

### **Standard Applicable**

For intentional device, according to § 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device.

And according to § 15.247 (1), if transmitting antennas of directional gain greater than 6 dBi are used the power shall be reduced by the amount in dB that the directional gain of the antenna exceeds 6 dBi.

### **Antenna Connected Construction**

The directional gain of the antenna used for transmitting is 0.41 dBi. The antenna is installed by OET integrator.

### §15.205, & §15.209(a) - SPURIOUS RADIATED EMISSION

### **Measurement Uncertainty**

All measurements involve certain levels of uncertainties. The factors contributing to uncertainties are spectrum analyzer, cable loss, antenna factor calibration, antenna directivity, antenna factor variation with height, antenna phase center variation, antenna factor frequency interpolation, measurement distance variation, site imperfections, mismatch (average), and system repeatability.

Based on NIS 81, The Treatment of Uncertainty in EMC Measurements, the best estimate of the uncertainty of a radiation emissions measurement at BACL is  $\pm 4.0$  dB.

### **EUT Setup**

The radiated emission tests were performed in the open area 3-meter test site, using the setup in accordance with the ANSI C63.4-2001. The specification used was the FCC 15 Subpart C limits.

The spacing between the peripherals was 10 centimeters.

External I/O cables were draped along the edge of the test table and bundle when necessary.

The notebook PC system was connected with 120Vac/60Hz power source.

### Spectrum Analyzer Setup

According to FCC Rules, 47 CFR §15.33 (a) (1), the system was tested to 25GHz.

During the radiated emission test, the spectrum analyzer was set with the following configurations:

Frequency Range	RBW	Video B/W
Below 30MHz	10kHz	10kHz
30 – 1000MHz	100kHz	100kHz
Above 1000MHz	1MHz	1MHz

### **Test Equipment List and Details**

Manufacturer	Description	Model	Serial Number	Cal. Date
HP	Spectrum Analyzer	8568B	2601A02165	2003-07-03
HP	Amplifier	8447E	2944A10187	2003-09-23
HP	Quasi-Peak Adapter	85650A	3019A05393	2003-06-13
EMCO	Biconical Antenna	3110B	9309-1165	2003-10-11
ЕМСО	Log Periodic Antenna	3146	2101	2003-10-11
A.H. Systems, Inc.	DRG Horn Antenna	SAS-200/571	261	2003-08-02

\* **Statement of Traceability: BACL Corp.** certifies that all calibrations have been performed in accordance to NVLAP requirements, traceable to the NIST.

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### **Test Procedure**

For the radiated emissions test, the Host PC system power cord was connected to the AC floor outlet since the power supply used in the EUT did not provide an accessory power outlet.

Maximizing procedure was performed on the six (6) highest emissions to ensure EUT compliance is with all installation combinations. All data was recorded in the peak detection mode. Quasi-peak readings was performed only when an emission was found to be marginal (within -4 dB $\mu$ V of specification limits), and are distinguished with a "**Qp**" in the data table.

#### **Corrected Amplitude & Margin Calculation**

The Corrected Amplitude is calculated by adding the Antenna Factor and Cable Factor, and subtracting the Amplifier Gain from the Amplitude reading. The basic equation is as follows:

Corr. Ampl. = Indicated Reading + Antenna Factor + Cable Factor - Amplifier Gain

The "**Margin**" column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of  $-7dB\mu V$  means the emission is  $7dB\mu V$  below the maximum limit for Subpart C. The equation for margin calculation is as follows:

Margin = Corr. Ampl. – Subpart C Limit

#### **Summary of Test Results**

According to the data in following table, the EUT <u>complied with the FCC Title 47, Part 15, Subpart C,</u> <u>section 15.205, 15.207 and 15.247</u>, and had the worst margin of:

-13.43 dB at 7206.00 MHz in the Vertical polarization, Low Channel

-13.36 dB at 7323.00 MHz in the Horizontal polarization, Middle Channel

-13.56 dB at 7440.00 MHz in the Vertical polarization, High Channel

-12.53 dB at 59.75 MHz in the Horizontal polarization, Unintentional Emission

#### **Environmental Conditions**

Temperature:	18° C
Relative Humidity:	57%
ATM Pressure:	1125 mbar

Ambit Microsystems Corporation

FCC ID: MCLT60M665

	INDICATE	D	TABLE	Anti	ENNA	Corr	RECTION FAC	CTOR	CORRECTED		C 15
<b>Francisco</b> (	Amend	Commonte	Angela	Llaiabt	Dalar			AMPLITUDE	SUBP.		
Frequency	Ampl.	Comments	Angle	Height	Polar	Antenna	Cable	Amp.	Corr. Ampl.	Limit	Margin
MHz	dBµV/m		Degree	Meter	H/ V	dBµV/m	DB	DB	dBµV/m	dBµV/m	dB
		1 1		Low	Channel	, 1 – 25 G	Hz				
2402	97.50	FUND/PEAK	0	1.4	V	28.1	3.35	35.2	93.75		
2402	89.67	FUND/PEAK	0	2.0	Н	28.1	3.35	35.2	85.92		
2402	96.80	FUND/AVE	0	1.4	V	28.1	3.35	35.2	93.05		
2402	89.17	FUND/AVE	0	2.0	Н	28.1	3.35	35.2	85.42		
7206	33.33	AVE	100	1.2	V	35.1	5.65	33.5	40.58	54	-13.43
7206	33.30	AVE	30	1.6	Н	35.1	5.65	33.5	40.55	54	-13.46
4804	32.00	AVE	90	1.2	V	32.5	4.91	33.0	36.41	54	-17.59
4804	31.90	AVE	45	1.0	Н	32.5	4.91	33.0	36.31	54	-17.69
7206	45.83	PEAK	30	1.6	Н	35.1	5.65	33.5	53.08	74	-20.93
7206	45.67	PEAK	100	1.2	V	35.1	5.65	33.5	52.92	74	-21.09
4804	44.50	PEAK	45	1.0	Н	32.5	4.91	33.0	48.91	74	-25.09
4804	44.33	PEAK	90	1.2	V	32.5	4.91	33.0	48.74	74	-25.26
		1			Middle (	Channel			1		
2441	98.50	FUND/PEAK	15	1.0	V	28.1	3.35	35.2	94.75		
2441	91.50	FUND/PEAK	250	1.8	H	28.1	3.35	35.2	87.75		
2441	98.00	FUND/AVE	15	1.0	V	28.1	3.35	35.2	94.25		
2441	91.00	FUND/AVE	250	1.8	H	28.1	3.35	35.2	87.25		
7323	33.40	AVE	270	1.8	H	35.1	5.65	33.5	40.65	54	-13.36
7323	33.30	AVE	90	1.4	V	35.1	5.65	33.5	40.55	54	-13.46
4882	32.10	AVE	30	1.4	V	32.5	4.91	33.0	36.51	54	-17.49
4882	31.80	AVE	180	1.6	H	32.5	4.91	33.0	36.21	54	-17.79
7323	46.10	PEAK	270	1.8	H	35.1	5.65	33.5	53.35	74	-20.66
7323	45.50	PEAK	90	1.4	V	35.1	5.65	33.5	52.75	74	-20.00
4882	44.80	PEAK	30	1.4	V	32.5	4.91	33.0	49.21	74	-24.79
4882	44.30	PEAK	180	1.6	H	32.5	4.91	33.0	48.71	74	-25.29
4002	ЭЧ.30	TEAK	100	1.0	High C		<b>Т</b> .71	55.0	40.71	/ 4	-23.27
2400	00 (7		20	1.7			2.25	25.2	04.02		
2480	98.67	FUND/PEAK	30	1.5	V	28.1	3.35	35.2	94.92		
2480	90.83	FUND/PEAK	330	2.2	H	28.1	3.35	35.2	87.08		
2480	98.00	FUND/AVE	30	1.5	V	28.1	3.35	35.2	94.25		
2480	90.17	FUND/AVE	330	2.2	H	28.1	3.35	35.2	86.42		
7440	33.20	AVE	60	1.5	V	35.1	5.65	33.5	40.45	54	-13.56
7440	33.10	AVE	0	1.2	Н	35.1	5.65	33.5	40.35	54	-13.66
4960	32.30	AVE	0	1.5	V	32.5	4.91	33.0	36.71	54	-17.29
4960	32.00	AVE	45	2.0	Н	32.5	4.91	33.0	36.41	54	-17.59
7440	46.20	PEAK	60	1.5	V	35.1	5.65	33.5	53.45	74	-20.56
7440	45.70	PEAK	0	1.2	Н	35.1	5.65	33.5	52.95	74	-21.06
4960	45.10	PEAK	0	1.5	V	32.5	4.91	33.0	49.51	74	-24.49
4960	44.60	PEAK	45	2.0	Н	32.5	4.91	33.0	49.01	74	-24.99

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	Indicated		Table	Antenna		Сс	prrection Fac	tor	FCC 15 Subpart B	
Frequency	Ampl.	Direction	Height	Polar	Antenna	Cable Loss	Amp.	Corr. Ampl.	Limit	Margin
MHz	dBµV/m	Degree	Meter	H/V	dBµV/m	dBµV/m	dB	dBµV/m	dBµV/m	dB
59.75	44.67	0	1.5	Н	9.8	1.70	28.7	27.47	40.0	-12.53
71.74	44.50	45	1.4	Н	9.2	1.16	28.8	26.06	40.0	-13.94
122.90	46.83	60	1.8	V	11.7	1.57	28.6	31.50	43.5	-12.00
241.30	46.00	60	1.0	Н	13.8	2.17	28.2	33.77	46.0	-12.23
252.50	41.67	90	1.5	V	13.3	2.17	27.8	29.34	46.0	-16.66
432.10	42.80	330	1.6	Н	16.9	2.79	28.3	34.19	46.0	-11.81
480.10	43.17	270	1.5	V	18.3	3.10	28.9	35.67	46.0	-10.33

### Note:

AVG = average

## **§15.207(a) - CONDUCTED EMISSIONS**

### **Measurement Uncertainty**

All measurements involve certain levels of uncertainties. The factors contributing to uncertainties are spectrum analyzer, cable loss, and LISN.

Based on NIS 81, The Treatment of Uncertainty in EMC Measurements, the best estimate of the uncertainty of any conducted emissions measurement at BACL is  $\pm 2.4$  dB.

### EUT Setup

The measurement was performed in the shielded room, using the same setup per ANSI C63.4-2001 measurement procedure. The specification used was FCC 15 Subpart C limits.

The spacing between the peripherals was 10 centimeters.

External I/O cables were draped along the edge of the test table and bundle when necessary.

The notebook PC system was connected with 120Vac/60Hz power source.

### Spectrum Analyzer Setup

The EMI test receiver was set to investigate the spectrum from 150 kHz to 30Mhz.

### **Test Equipment List and Details**

Manufacturer	Description	scription Model Se		Cal. Date
Rohde & Schwarz	Artificial LISN	ESH2-Z5	871884/039	2003-03-28
Rohde & Schwarz	EMI Test Receiver	ESCS30	100176	2003-05-06

\* **Statement of Traceability: BACL Corp.** certifies that all calibrations have been performed in accordance to NVLAP requirements, traceable to the NIST.

### **Test Procedure**

During the conducted emission test, the power cord of the host system was connected to the auxiliary outlet of the first LISN.

Maximizing procedure was performed on the six (6) highest emissions of each modes tested to ensure EUT is compliant with all installation combination.

All data was recorded in the peak detection mode. Quasi-peak readings were only performed when an emission was found to be marginal (within -4 dB $\mu$ V of specification limits). Quasi-peak readings are distinguished with a "**Qp**".

### **Summary of Test Results**

According to the data in following table, the EUT <u>complies with the FCC</u> Conducted margin for a Class B device, with the *worst* margin reading of:

-17.4 dB $\mu$ V at 4.41 MHz in the Neutral mode

### **Conducted Emissions Test Data**

### **Environmental Conditions**

Temperature:	18° C
Relative Humidity:	57%
ATM Pressure:	1125 mbar

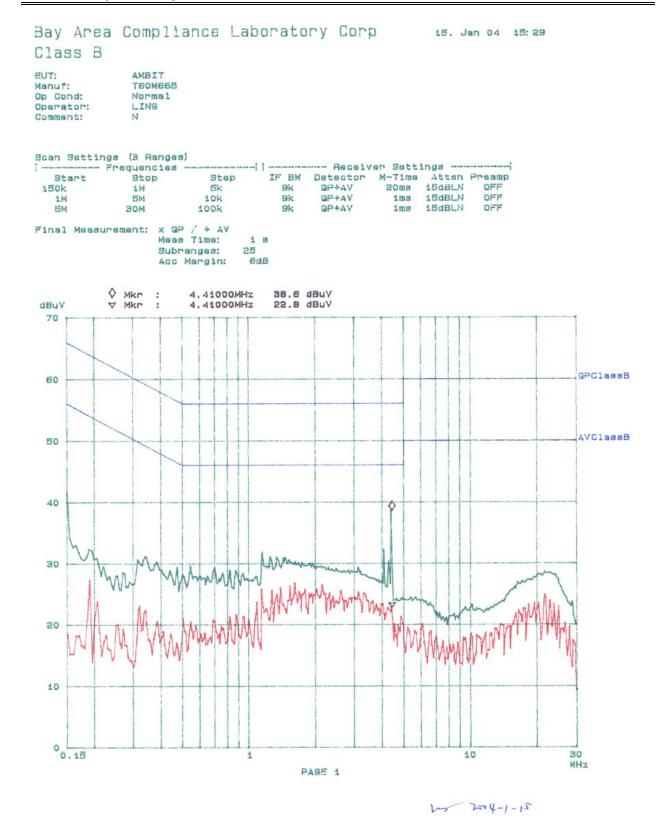
LINE CONDUCTED EMISSIONS			FCC PART 15 CLASS B		
Frequency	Amplitude	Detector	Phase	Limit	Margin
MHz	dBµV	Qp/Ave/Peak	Line/Neutral	dBμV	dB
4.41	38.60	QP	Neutral	56	-17.40
0.15	37.80	AVG	Line	56	-18.20
0.15	43.60	QP	Line	66	-22.40
4.41	22.80	AVG	Neutral	46	-23.20
4.08	32.20	QP	Neutral	56	-23.80
0.4	23.70	AVG	Line	47.9	-24.15
4.08	21.70	AVG	Neutral	46	-24.30
0.15	41.40	QP	Neutral	66	-24.60
21.8	25.00	AVG	Line	50	-25.00
0.405	31.80	QP	Line	57.8	-25.95
0.19	27.50	AVG	Neutral	54	-26.54
21.6	29.80	QP	Line	60	-30.20

### **Plot of Conducted Emissions Test Data**

Plot(s) of Conducted Emissions Test Data is presented hereinafter as reference.

#### Bay Area Compliance Laboratory Corp 15. Jan 04 15:49 Class B EUT: AMBIT T60M665 Manuf: Op Cond: Normal Operator: LING Comment: L Scan Settings (3 Ranges) --- Frequencies ------ Receiver Settings ------1 -IF BW Detector M-Time Atten Preamp Start Stop Step 150k 1M 5k 9k QP+AV 20ma 15dBLN OFF 1M 5M 10k 9k QP+AV 1ms 15dBLN OFF 5M NOE 100k 9k QP+AV 1ms 15dBLN OFF Final Measurement: x QP / + AV Meas Time: 1 8 25 Subranges: 6dB Acc Margin: ♦ Mkr 150.00 kHz 43.6 dBuV : 37.8 dBuV dBuV V Mkr : 150.00 kHz 70 QPC1assB 60 AVClassB 50 ٥ 40 30 20 MIN 10 0.15 10 30 1 MHz PAGE 1 In 200 4-1-15

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